Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination
10/517,323	NISHIKAWA ET AL.
Examiner	Art Unit
Melissa S. Mercier	1615

	SEAR	CHED	
Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

(INCLUDING SEARCH	STRATEGY	<u> </u>
	DATE	EXMR
East-see attached	9/28/2007	MSM
STN structure search-see attached	9/27/2007	MSM
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